Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/768,650	NAKANISHI ET AL.
Examiner	Art Unit

3748

BINH Q. TRAN

SEARCHED							
Cla	ıss	Subclass	Date		Examiner		
60	)	274	05/24/05		- R5		
		275				1	
		286					
		297					
		301					
1		303	1		7		
42	2	186.03	05/24	/ps	B	5	
		186.04	,	1		1	
		186.07					
		186.24	\		\	<u> </u>	

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
	·					
1						

SEARCH NOTES (INCLUDING SEARCH STRATEGY)						
	DATE	EXMR				
EAST TEXT SEARCHED	ospups	<i>B</i> 5				